# Disordered electronic systems. II. Phase separation and the metal-insulator transition in metal-metalloid alloys

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The electronic transport in the phase separated regime is determined by both the different *local band* structure in the phases (called phases A and B) and electron redistribution (electron transfer) to the phase with the deeper average potential (phase B). Equations for the dependence of the electronic conductivity  $\sigma$  on metalloid concentration x are derived. In amorphous metal-metalloid alloys the metal-insulator transition (M-I transition) characterized by the transition from  $\sigma > 0$  to  $\sigma = 0$  at temperature T = 0 at  $x = x_c$  takes place in the phase separated regime. The M-I transition in  $S_{1-x}M_x$  alloys is determined by the conduction band (phase A), whereas in  $N_{1-x}M_x$ , and in many  $T_{1-x}M_x$  alloys, it is determined by the valence band (phase B) (N and T stand for a transition metal with completely and incompletely occupied d band, respectively, S for a simple metal as Al, Ga, In,..., and M for a metalloid element as Si or Ge). (1) Granular structure, (2) rapid decrease of the average metal grain size with increasing x, and (3) relatively small  $x_c$  are characteristic features for  $S_{1-x}M_x$  thin films deposited under extreme deposition conditions and are caused by the fact that a considerable part of electrons transferred occupy surface states leading to charged phase boundaries. The *fractal* structure found in  $Al_{1-x}Ge_x$  alloys after annealing is related with the formation of a maximum of phase boundary faces for acceptance of the transferred electrons. For strong scattering in a single phase, there are a minimum metallic conductivity  $\sigma_{\min} \simeq (c^*/6)(e^2/h)(1/d)$  and mobility edges at density of states  $4c^*m/h^2d$ , where  $c^*=1/4$  (d is the average atomic distance. e and m are the elementary charge and effective mass of the electrons, respectively, and  $\hbar = h/2\pi$  is Plancks constant).

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## I. INTRODUCTION

The metal-insulator transition (M-I transition) in disordered electronic systems is one of the most challenging problems in condensed matter science. "The fundamental question, still unsolved after almost half a century of intense study, is whether the electrical conductivity vanishes discontinuously...or smoothly...at the transition" (Edwards et al.).<sup>1</sup> This is immediately connected with the question of whether there exists a minimum metallic conductivity  $\sigma_{\min}$  as originally proposed by Mott.<sup>2,3</sup> Today, it is generally believed that the M-I transition is continuous in threedimensional systems and that there is not a  $\sigma_{\min}$  in accordance with the predictions of the scaling theory of localization.<sup>4,5</sup> Already 2 decades ago Thouless<sup>6</sup> regarded "the concept of minimum metallic conductivity as one of the creative errors that helped the progress of science." For metal-metalloid alloys this point of view seems to be in good correspondence with experimental results.<sup>7-9</sup> Nevertheless, there is also support for Mott's original proposal (Möbius et al.<sup>10-15</sup>), and the existence of a  $\sigma_{\min}$  is considered to be a possible scenario, when electron-electron interaction is taken into account.<sup>1</sup> For amorphous alloys a random and homogeneous distribution of the metal atoms in the amorphous matrix is often assumed, and the M-I transition is generally accepted to be a type of Anderson transition,  $^{16-23}$  where the *potential disorder* plays the most important role.<sup>24,25</sup>

In contrast to this view, in the first part<sup>26</sup> of the present paper series (called Pap. I in the following), an alternative and independent discussion was presented for the metallic regime of amorphous transition-metal-metalloid alloys with the following *conclusions*.

For large ranges of concentration there is

(i) *amorphous phase separation* between two different amorphous phases called phase *A* and phase *B*, where each phase has its "own" short-range order (SRO),

(ii) the amorphous phase separation leads to band separation in the conduction band (CB) and valence band (VB) connected with the phases A and B, respectively, and the electrons are freely propagating and the corresponding wave functions are extended with respect to connected phase ranges, and

(iii) between the two coexisting phases there is *electron redistribution* (*electron transfer*) which can be described by

$$n(\zeta) = n_A \exp(-\beta \zeta), \tag{1}$$

where  $\zeta$  is the quotient of the volume or atomic fractions of the two coexisting phases.<sup>27</sup>  $n(\zeta)$  is the electron density in the phase *A* with  $n_A = n(0)$ .  $\beta$  is a constant for a given alloy, which is determined by the average potential difference between the two phases.

Conclusion (i) amorphous phase separation is now confirmed experimentally for a series of amorphous transition-metal-metalloid alloys: Edwards *et al.*<sup>28</sup> reported on measurements of radio frequency reactive cosputtered a-Ni<sub>1-x</sub>Si<sub>x</sub>: H using Raman spectroscopy, infrared absorption and extended x-ray absorption fine structure (EXAFS) that for x > 0.7 there is indication for close-packed Si:Ni clusters beside an *a*-Si matrix and they speculated that the system contains two amorphous phases: one being semiconducting and the other being semi-metallic. For a-Au<sub>1-x</sub>Ge<sub>x</sub> (x

>0.63) Edwards *et al.*<sup>29</sup> concluded from EXAFS that regions of a Ge-Au alloy are embedded in amorphous Ge host network. From small-angle x-ray scattering and x-rayabsorption near-edge spectroscopy experiments at cosputtered a-Fe<sub>1-x</sub>Ge<sub>x</sub> films with 0.28 < x < 0.63Lorentz et al.<sup>30</sup> concluded phase separation into two phases likely to be a-FeGe<sub>2</sub> and a-Fe<sub>3</sub>Ge. Applying anomalous small-angle x-ray scattering (ASAXS), Regan et al.<sup>31</sup> found in cosputtered a-W<sub>1-x</sub>Ge<sub>x</sub>, a-Fe<sub>1-x</sub>Ge<sub>x</sub>, a-Fe<sub>1-x</sub>Si<sub>x</sub>, and  $a-Mo_{1-r}Ge_r$  films phase separated regions of the order of 1 nm in the growth plane and 1.5-2.0 nm in the growth direction. They could show that their measurements are in agreement with the assumption of two coexisting amorphous phases, a-Ge or a-Si, on the one side and a metallic phase with FeGe<sub>2</sub>, FeSi<sub>2</sub>, or MoGe<sub>3</sub> compositions for the last three systems, respectively, on the other side. Raap et al.<sup>32</sup> found amorphous phase separation in cosputtered a-Fe<sub>1-r</sub>Si<sub>r</sub> films into regions of a-Si and an intermetallic close in composition to a-FeSi<sub>2</sub> with  $\sim 0.6$  nm in the film plane and  $\sim 1$  nm in size in the growth direction using ASAXS.

Support for the *conclusion* (*ii*) comes from measurements of the electronic specific heat coefficient  $\gamma$  of a-Mo<sub>1-x</sub>Ge<sub>x</sub> (Yoshizumi *et al.*),<sup>33,34</sup> a-Au<sub>1-x</sub>Si<sub>x</sub> (Fischer and Löhneysen),<sup>35</sup> a-Vi<sub>1-x</sub>Si<sub>x</sub> (Mizutani *et al.*),<sup>36</sup> and a-Ti<sub>1-x</sub>Si<sub>x</sub> (Rogatchev *et al.*):<sup>37</sup>  $\gamma$  does not go to zero at the M-I transition, but varies smoothly across the M-I transition. Support for *conclusion* (*ii*) comes also from the result by Abkemeier *et al.*<sup>38,39</sup> who found by an analysis of conductivity data in a-Ni-Si: H on the insulating side that a consistent interpretation is obtained, if it is assumed that the *wave functions of the electrons contributing to conduction are extended through clusters* of metal atoms and only localized by longer-range disorder, where the metal atoms are assumed to be Ni.

*Conclusion* (iii) is not yet confirmed or supported by independent authors.

The convincing confirmation and support for *conclusions* (i) and (ii) is the motivation for the present publication: purpose is a consistent description of the connection between SRO and electronic transport in metal-metalloid alloys as a basis for the description of the M-I transition. Basis for the present paper is the *amorphous phase separation model* of Pap.I with the CB and VB connected with phases A and B, respectively.

An electron moving through the alloy is *not restricted to a single phase*, but it can overcome the phase boundaries, provided both the CB and the VB are incompletely occupied. The crucial point is that in the two different phases, this electron is exposed to different local band structures (1) with different densities of states at the Fermi level (2) depending on the local band structure and the distribution of the electrons to the available electronic bands.

Applying known valence band spectra in Sec. II a microscopical model is developed for describing the electronic structure and electronic transport in metal-metalloid alloys which takes into account in particular

1. the internal surfaces (phase boundaries),

2. the average compositions of the two phases, and

3. electron redistribution (electron transfer) between the phases.

On the basis of this microscopical model, in Sec. III the effect of both the local band structure and the electron distribution between the phases on the electronic conductivity  $\sigma$  is considered applying effective medium theory (EMT) and the Boltzmann transport equation (BTE), and equations for the concentration dependence of  $\sigma$  are derived.  $\sigma(x)$  closed to the M-I transition is calculated and compared with experimental results published in the literature.

In Sec. IV the application of the EMT and BTE for description of the electronic transport in disordered alloys will be justified under especial consideration of phase separation and the Ioffe-Regel criterion, and formulae for a minimum metallic conductivity and mobility edges are derived, both related to a single phase. In Sec. V the results are summarized.

# **II. SHORT RANGE ORDER AND ELECTRONIC STRUCTURE OF METAL-METALLOID ALLOYS**

# A. $N_{1-x}M_x$ and $T_{1-x}M_x$ alloys

a-Si or a-Ge represent one of the possible phases in  $a - N_{1-x}M_x$ ,  $a - T_{1-x}M_x$ , and granular  $S_{1-x}M_x$  alloys.<sup>28-32,40-45</sup>  $(N \text{ and } T \text{ stand for a transition metal with completely and } T \text{ stand for a$ incompletely occupied d band, respectively, S for a simple metal as Al,Ga,In,..., and M for a metalloid element as Si or Ge.) Since the early 1970s it is known<sup>46-55</sup> that evaporated thin a-Si or a-Ge films have a heterogeneous structure characterized by density fluctuations: relatively closed packed ranges ("high density islands") are separated by ranges with smaller density ("low density channels"). The average island diameters were found to be of the order of 10 nm.<sup>46-50,52</sup> The high density islands have a higher degree of order in comparison with the low density channels.<sup>49-51</sup> During the film deposition process there is a competition between nucleation and growth of the high density islands (similar to the crystallization process in crystalline films, however, with structures without long-range order, but with a defined SRO characterized by the tetrahedral coordination typical for a-Si and a-Ge).<sup>48</sup> These nuclei (islands) grow until they are embedded by the neighboring grains. Now the conditions for undisturbed formation of this SRO are no longer given concerning the bonds being required angles and distances for an ideal tetrahedral bonding condition<sup>48</sup> and this "misfit" between the bordering islands on each other leads to the low density channels characterized by an essentially larger density of defect states (dangling bonds, vacancies, etc.). The resulting inhomogeneous structure may in fact be well described as "polyamorphous"<sup>53</sup> in analogy to the "polycrystalline" counterparts. According to the Davis-Mott model<sup>56</sup> such defects form a band of localized states near the middle of the energy gap between the valence band and the conduction band (of the *elemental* semiconductor a-M) where the Fermi level is pinned.

Regarding the formation kinetics in  $a-N_{1-x}M_x$  films, e.g.,  $a-Au_{1-x}Si_x$ , we expect an analogous situation as in *a*-Si films, however, with the difference that the growth of the *a*-Si islands is not only limited by bordering *a*-Si islands. The growth of the *a*-Si islands is also limited by the fact that there is a second atomic sort (Au) and that there can be local

fluctuations of the Au-atom distribution during the deposition process, so that also nuclei with the  $a - \mu$  structure<sup>43-45</sup> can grow beside a-Si nuclei. Although the mobility of the atoms is small (but not zero at usual deposition temperatures), amorphous structures are expected with a formation enthalpy as small as possible, under the given conditions. So we are again led to the hypothetical free-energy diagram for a-Au<sub>1-x</sub>Si<sub>x</sub> proposed by Mangin *et al.*,<sup>43,44</sup> already applied in Pap. I (Fig. 6 in Pap. I). According to this free-energy diagram we expect within the concentration range  $0.3 \leq x < 1$ two different amorphous phases coexisting side by side similar to the situation in crystalline materials with intermediate phases, i.e., the metal atoms are not incorporated in a continuous random network during growth of the thin film, but they form (with part of the Si atoms) a second amorphous phase (phase A), which occurs in addition to the *a*-Si phase (phase B).

The SRO in the *B* phase (a-Si) corresponds to the tetrahedrally coordinated SRO in a-Si, whereas the SRO of the A phase corresponds to close-packed structure typical for metallic phases,<sup>43</sup> and between the two phases there are boundary faces analogous to the low density channels in a-Si, because the growth of the B-phase nuclei is disturbed approaching neighboring nuclei leading to a strong disturbance of the SRO in the boundary faces. In this, we have to distinguish two different kinds of boundary faces such between two B-phase grains, on the one hand, and those between an B-phase grain and an A-phase grain, on the other hand. In the latter case the density of defect states is expected to be essentially larger than between two B-phase grains, if the bond orbitals of the B atoms (Si) have the  $sp^3$  hybrid configuration typical for tetrahedral atom coordination, whereas overlapping of the wave functions is rather possible between the Si atoms (with  $sp^3$  hybrid configuration) of different grains of the same phase sort, also when the required angles and distances for an ideal tetrahedral bonding condition (for *B* phase) are only approximately fulfilled. Therefore, we assume that part of the Si atoms (especially those of a B phase grain which immediately border on an A phase grain—called  $B^*$  atoms in the following, Figs. 1 and 2) have  $s^2p^2$  configuration,<sup>57</sup> and the *p* orbitals of these  $B^*$  atoms overlap with d orbitals of the metal atoms in the A phase grains and p orbitals of other  $B^*$  atoms in the immediate neighborhood. This assumption is suggested by published valence band spectra of some amorphous transition metalmetalloid alloys:

In Fig. 3 the x-ray photoemission spectra of a-Cr<sub>1-x</sub>Si<sub>x</sub> alloys taken from Kobayashi *et al.*<sup>58</sup> are reproduced. In agreement with *conclusion* (*i*) and analogous to the a- $N_{1-x}M_x$  alloys, for a-Cr<sub>1-x</sub>Si<sub>x</sub>, a- $\mu$ , and a-Si are assumed as possible *amorphous* phases with the compositions  $x_A \approx 0.3$  and  $x_B \approx 1.^{59}$  The spectra in Fig. 3 can be considered as an addition of those of the two coexisting amorphous phases weightened according to their volume fractions. Between x = 0.312 ("Cr-31.2 at.% Si") and x=0.806 ("Cr-80.6 at.% Si") there is a common single peak at the same binding energy,  $E_b \approx -9$  eV, called peak 1, the peak height increases continuously with increasing Si content and can, therefore, be assigned to the *a*-Si phase, since the volume fraction. In the Si



FIG. 1. Amorphous phase separation in  $a-N_{1-x}M_x$  alloys for  $v_B < 1/3$ , where  $v_B$  is the volume fraction of the *B* phase.  $B^*$  characterizes the internal surfaces (monoatomic surface layers of the *B*-phase grains) which are assumed to have  $s^2p^2$  configuration.  $B_0$  characterizes the core atoms of the *B* phase grains assumed to have  $sp^3$  configuration. The grain sizes are approximated by spheres with an average diameter of the order of  $\approx 1$  nm.

spectrum, this peak 1 is, however, no longer resolved, but it is merged (fused) with a considerable density of states distribution ranging until near to the energy where the energy gap of Si begins to open. Since for the Cr containing alloys  $(x \le 0.806)$  such a very big fraction of this density of states distribution (representing the bonding  $sp^3$  hybrid orbitals of Si) fails (at least) in the energy range between about -5 and -8 eV, there is reason for the assumption that the states belonging to the  $B^*$  atoms ( $x \le 0.806$ ) are provided by states which in *a*-Si (i.e.,  $x \approx 1$ ) would be in this energy range, and the conclusion is suggested that part of the Si atoms, very probably the  $B^*$  atoms in the B phase (a-Si), have no longer  $sp^3$  hybrid configuration, but that the bonds are realized by p orbitals which overlap with p orbitals of neighboring  $B^*$  atoms and d orbitals of the Cr atoms (of the A phase grains) as assumed earlier. This assumption is also supported by Si K $\beta$ emission spectra published by Tanaka et al.<sup>60</sup> of amorphous and crystalline  $Ni_{1-x}Si_x$  and  $Pd_{1-x}Si_x$  alloys: beside *bonding* Si p states also part of the corresponding antibonding Si p states lie below the common Fermi level  $\mu$  (chemical potential), and they are shifted to lower energy, when the metalloid



FIG. 2. Same as Fig. 1, but for  $v_B > v_{B,k}$ .



FIG. 3. X-ray photoemission spectra of a-Cr<sub>1-x</sub>Si<sub>x</sub> taken from Kobayashi *et al.* (see Ref. 58).

content is increased, i.e., they are partially occupied by electrons, and this occupation increases with increasing metalloid content. Regarding these spectroscopic results<sup>58,60</sup> and the earlier considerations, the following band sketch can be drawn for the two-phase range between a-Si (or a-Ge) and the next amorphous phase, Fig. 4. The band sketch of Fig. 4, drawn for  $a - N_{1-x}M_x$  alloys, relates to  $a - T_{1-x}M_x$  alloys as well, on principle, where additionally we have to take into account that the next amorphous phase (beside a-Si) can be different from a composition  $a-N_3M$   $(a-\mu)$ , e.g.,  $a-TM_3$  or  $a-TM_2$ .<sup>30–32,42</sup> Which amorphous phases in an  $a-T_{1-x}M_x$  alloy are realized, one cannot say generally, since the corresponding (equilibrium) phase diagram $^{61,62}$  only is a rough guide for possible amorphous phases with the same composition. For instance, Ishii et al.<sup>40</sup> found an amorphous MoGe<sub>3</sub> phase which has no known crystalline counterpart. On the other hand, it seems that the amorphous counterpart to the known<sup>63,64</sup> c-SiCr<sub>2</sub> phase is not realized<sup>59</sup> in the specimens by Kobayashi et al.58

From the fact that at least part of the *antibonding* p states are below the Fermi level  $\mu$ ,<sup>60</sup> the VB can be assumed to consist of bonding p and antibonding p states (from  $B^*$  at-



FIG. 4. Schematic band model for an  $a-N_{1-x}M_x$  alloy: Densities of states  $N_A(E)$  and  $N_B(E)$  in dependence on energy E in the two phases A and B, phase A on the left-hand side, phase B on the right-hand side (d states or bands are not drawn). The VB consists of bonding p and antibonding p states of the mono-atomic layer of M atoms adjacent to A phase grains ( $B^*$ ) and bonding  $sp^3$  states of the atoms within the B phase cores ( $B_0$ ) as drawn schematically in Figs. 1 and 2.  $\mu$  characterizes the common Fermi level (chemical potential) of the alloy.

oms) and bonding  $sp^3$  states arising from *core* atoms of the *B* phase grains (called  $B_0$  atoms in the following), and that for the VB generally hole conductivity is expected, because both a considerable part of the antibonding p states (of the  $B^*$ atoms) and the bonding  $sp^3$  states (of the  $B_0$  atoms) are below  $\mu$ ,<sup>60</sup> whereas all the antibonding  $sp^3$  states (of the  $B_0$ atoms) are above the VB separated by an energy gap. The considerable fraction of antibonding p states below  $\mu$  suggests also a considerable electron transfer from the A phase to the *B* phase [notice that also part of the electrons in the *B* phase occupy s states (of the  $B^*$  atoms) lying at energies below the bonding p states].<sup>60</sup> The carriers in the VB are considered to be freely propagating within connected Bphase ranges as long as  $\mu$  is below the top of the VB, or more precise, below the upper mobility edge of the VB (Sec. IV D).

There is an essential difference between the spectra by Kobayashi *et al.*<sup>58</sup> (from "Cr-31.2 at.% Si" to "Cr-55.5 at% Si") and those by Tanaka *et al.*:<sup>60</sup> For *a*-Ni<sub>1-x</sub>Si<sub>x</sub> (with  $x \le 0.53$ )<sup>60</sup> peak 1 assigned earlier to the *a*-Si phase in *a*-Cr<sub>1-x</sub>Si<sub>x</sub> is not visible suggesting the fact that in the *a*-Ni<sub>1-x</sub>Si<sub>x</sub> alloys, the second phase *B* is not *a*-Si, but a phase with another composition, possibly *a*-NiSi<sub>2</sub>. A corresponding crystalline phase, *c*-NiSi<sub>2</sub>, is known.<sup>61-64</sup>

Summarizing, the existence of the phase boundary faces A/B allows the acceptance of a considerable amount of additional electrons (transferred from the A phase to the B phase) in the VB: Each  $B^*$  atom provides eight electronic

states (three bonding p, three antibonding p, and two s states), whereas each  $B_0$  atom provides only four electronic states (i.e., four bonding  $sp^3$  states) to the VB. That is why, for a later calculation of the hole density in the VB, determination of the (atomic) fraction of the boundary face atoms  $B^*$ ,  $X_{B^*}$ , is important. In the following, we have to distinguish between *volume* fractions,  $v_A$  and  $v_B$ , and *atomic* fractions,  $X_A$  and  $X_B$ , of the phases A and B, respectively.  $v_{B^*}$ ,  $v_{B_0}$  are the *volume* fractions, and  $X_{B^*}$ ,  $X_{B_0}$  are the *atomic* fractions taking up by the  $B^*$ ,  $B_0$  atoms, respectively.

Assuming the *A* and *B* phase grains being nearly spherical with the average diameters  $D_A$  and  $D_B$ , respectively, of the order of 1 nm, a typical value found experimentally for some  $a - T_{1-x}M_x$  alloys,<sup>32,31</sup> then  $v_{B^*}$  and  $p_0^*$ , the available hole density in the VB without electron transfer, can be relatively large, of the order of  $10^{22}$  cm<sup>-3</sup>, as long as  $v_B$  is not too large  $(v_B < 2/3)$ . With increasing  $v_B$ ,  $p_0^*$  decreases, because  $v_{B^*}/v_B$  decreases as  $\zeta_v$  increases, according to

$$\frac{\boldsymbol{v}_{B^*}}{\boldsymbol{v}_B} = \frac{1}{\zeta_v} \left[ \left( 1 + \frac{2d_B}{D_A} \right)^3 - 1 \right] \quad (\boldsymbol{v}_B > \boldsymbol{v}_{B,k}) \tag{2}$$

with

$$\zeta_v = \frac{v_B}{v_A},\tag{3}$$

$$\boldsymbol{v}_{B_0} + \boldsymbol{v}_{B^*} = \boldsymbol{v}_B, \tag{4}$$

$$v_A + v_B = 1, \qquad (5)$$

where  $d_B$  is the average atomic diameter of the  $B^*$  atoms and

$$v_{B,k} = 1 - \left(1 + \frac{2d_B}{D_A}\right)^{-3} / 3$$
 (6)

characterizes the volume fraction of the *B* phase, above it the  $B^*$  shells enveloping different *A* phase grains do not touch each other, see Fig. 2. For  $v_B > v_{B,k}$ , the fraction of the  $B^*$  atoms with  $s^2p^2$  configuration,  $X_{B^*}(v_{B^*})$ , related to the fraction of the  $B_0$  atoms with  $sp^3$  configuration,  $X_{B_0}(v_{B_0})$ , decreases rapidly with increasing  $X_B(v_B)$ , as the sum of all the boundary faces between the phases *A* and *B* decreases rapidly as well. Because of the electron transfer from the *A* phase to the *B* phase, the true hole density, *p*, is still smaller than  $p_0^*$ , but decreases as well, as  $X_B(v_B)$  increases, as will be studied quantitatively in Sec. III. On the other side, for  $v_B < 1/3$ ,  $v_{B^*}/v_B$  given by

$$\frac{v_{B^*}}{v_B} = \left[ 1 - \left( 1 - \frac{2d_B}{D_B} \right)^3 \right] \quad (v_B < 1/3), \tag{7}$$

is constant, if  $d_B/D_B$  is constant. For the concentration range  $1/3 < v_B < v_{B,k}, v_{B^*}/v_B$  is expected to decrease generally with increasing  $v_B$  or  $\zeta_{v_P}$  although it is difficult to give a quantitative relation, since part of the *B* surface atoms contact to each other having the  $sp^3$  orbital configuration (*B*/*B* phase boundary faces).

A *hole* contribution of the VB to the electronic transport (at T=0) can only occur, when at least the common Fermi

level  $\mu$  still lies energetically below the upper mobility edge in the VB (Sec. IV D) corresponding to a critical hole density  $p_{\text{crit}}$ . Summarizing, the concentration dependence of  $p_0^*$  accompanied with the electron transfer leads to the fact that the hole density in the VB, p, decreases generally with increasing  $v_B$ .

Between *a*-Si or *a*-Ge and the amorphous *alloys* there is still another essential structural difference: In thin a-Si or a-Ge films the high dense islands often are grown through the whole film, i.e., there is a preferred direction perpendicular to the substrate leading to grains similar to rods (columnar structure),<sup>51,52</sup> because the growth of the phase grains into the perpendicular direction against the substrate is generally not hindered by other phase grains; for energetic reasons the probability that hit atoms arrange rather to the already available, growing phase grains is larger than forming new nuclei. On the other hand, in the amorphous alloy the appearance of the second atomic sort disturb the growth of the phase grains into all directions, and it needs diffusion processes for growth of the phase grains which, however, are strongly depressed. Therefore, in amorphous alloys, phase grains with a spherical-similar structure are expected rather than a columnar structure as in *a*-Si or *a*-Ge.

The considerations to  $a - N_{1-x}M_x$  and  $a - T_{1-x}M_x$  alloys can be applied, on principle, to crystalline or partially crystalline  $N_{1-x}M_x$  and  $T_{1-x}M_x$  alloys as well. The differences are: the realized energetic state is generally lower and the mean free paths of the carriers are generally larger in a crystalline phase than in an *amorphous* one. Also the average (crystalline) phase grain sizes are expected to be larger and, therefore,  $(v_{B^*}/v_B)$  is smaller for a given  $\zeta_v$  leading to smaller hole densities  $p_0^*$  (and p, Sec. III B). The question of which kind of crystalline phases will be realized depends on different factors in a complex manner, where the free-energy difference between the amorphous and crystalline state and the activation energies for diffusion play an essential role. Considering a-Au-Si, a-Au-Ge, and a-Ag-Ge thin films, during annealing, first, (crystalline) Au or Ag precipitations<sup>43,44,65,66</sup> occur beside an a-Si or a-Ge phase, which crystallize as well, if the annealing temperature is sufficiently high leading to a phase mixing between c-Si or c-Ge and c-Au or c-Ag.61,62

# **B.** $S_{1-x}M_x$ alloys

For  $S_{1-x}M_x$  alloys the situation is comparable with those in  $N_{1-x}M_x$  and  $T_{1-x}M_x$  alloys, but with the following differences.

(1) A metastable phase with a composition  $S_3M$  corresponding to the  $\mu$  phase in  $a - N_{1-x}M_x$  alloys is not known in  $S_{1-x}M_x$  alloys and it seems that the phases S(M) and  $M(S)^{67}$  do play the crucial role,<sup>68</sup> where S(M) and M(S) means that M atoms are solved in an S matrix, and S atoms are solved in an M matrix, respectively. S(M) is the metallic phase, whereas M(S) is the semiconducting (insulating) phase. Deep on the metallic side the S(M) phase is generally found to be crystalline<sup>67,69–73</sup> and the mean free path in the phase A,  $L_A$ , is expected to be significantly larger than the average atomic distance in the metallic phase, d, whereas for

 $a - N_{1-x}M_x$  and  $a - T_{1-x}M_x$  alloys  $L_A \simeq d$  is conjectured in the phase A for x > 0.3 [in analogy to the example  $a - (\text{AgCu})_{1-x}\text{Ge}_x$ ].<sup>74</sup>

(2) If each *S* atom solved in the M(S) matrix (*B* phase) has the same  $sp^3$  hybrid configuration as the *M* atoms as well, then each solved *S* atom provides *one* additional state for acceptance of *one* electron (transferred from the *A* phase to the *B* phase), provided all the  $sp^3$  orbitals overlap with  $sp^3$  orbitals of neighboring *M* or *S* atoms [in the M(S) matrix] This condition can, however, only be fulfilled for the  $B_0$  atoms (Figs. 1 and 2), whereas for the phase boundary atoms,  $B^*$ , there are  $\nu$  orbitals per  $B^*$  atom, for which an overlap with another  $sp^3$  orbital is not possible, and the corresponding states are not available for the VB.  $\nu$  is of the order of 1.

(3) In  $S_{1-x}M_x$  alloys there are no *d* states and therefore no *d*-*p*-orbital bonds realizing chemical bond between atoms of the different phases are possible as in  $N_{1-x}M_x$  and  $T_{1-x}M_x$  alloys. Therefore, in  $S_{1-x}M_x$  alloys the boundary faces between phase grains of the *different* phases are assumed to be characterized by the transition from the tetrahedrally coordinated SRO with  $sp^3$  hybrid orbitals [phase B=M(S)] to the close-packed structure typical for metallic phases with  $s^2p$  orbitals<sup>57</sup> [phase A=S(M)].

# III. ELECTRONIC TRANSPORT AND THE M-I TRANSITION IN METAL-METALLOID ALLOYS

#### A. General considerations

If phase separation is realized, the electronic transport and the M-I transition cannot be described by a model which assumes a random and homogeneous distribution of the metal atoms in a disordered matrix. Instead, conclusion (i) (Sec. I) for amorphous transition-metal-metalloid alloys suggests the fact that the M-I transition at temperature T=0takes place due to percolation of a metallic component embedded in an insulating component.<sup>29,31,40</sup> Edwards et al.<sup>29</sup> concluded from structural studies of a-Au-Ge alloys, application of percolation theory is more appropriate than the Anderson delocalization approach. On the other hand, because of *conclusion (ii)* (Sec. I), both the CB and the VB can simultaneously contribute to the electronic transport, if they are incompletely occupied. If so, and if the VB is still incompletely filled beyond the percolation threshold with respect to the A phase, then the M-I transition at T=0 in disordered metal-metalloid alloys with phase separation cannot be described due to percolation of a metallic component embedded in an insulating component, but another theory is necessary, which considers separately the electronic transport properties in each of the two phases A and B.

If in a disordered alloy with phase separation both the CB and the VB are incompletely occupied, then an electron moving through the alloy is *not restricted to a single phase*, but it can overcome the phase boundaries as well. The crucial point is the fact that this electron is exposed to different local band structures (1) with different densities of states at the Fermi level (2), depending on the kind of phase (A and B) and filling of the available electronic bands. The local density of states in the two phases A and B,  $N_A(E)$  and  $N_B(E)$ , respec-

tively, at the common Fermi level are to be assumed, generally, as different from each other, Fig. 4. While the band structure (1) in a phase determines the behavior of this electron which can be described by the concept of the effective mass, the densities of states (2) determine the current densities under the influence of an electric field. In this view it is possible to assign "own" transport coefficients to each of the two phases,  $\sigma_A$ ,  $\alpha_A$ ,  $\kappa_{e,A}$ , and  $R_{H,A}$  for the phase A, and  $\sigma_B$ ,  $\alpha_B$ ,  $\kappa_{e,B}$ , and  $R_{H,B}$  for the phase B where  $\sigma_i$ ,  $\alpha_i$ ,  $\kappa_{e,i}$ , and  $R_{H,i}$ are the specific conductivity, the Seebeck coefficient (thermoelectric power), the electronic contribution to the specific thermal conductivity, and the Hall coefficient for the phase *i* (i=A,B). And, if the transport coefficients  $\sigma_i$ ,  $\alpha_i$ ,  $\kappa_{e,i}$ , and  $R_{H,i}$  for the phases are given, then the electronic transport coefficients of disordered alloys with phase separation can be described applying the EMT. For the specific electrical conductivity  $\sigma$  let us apply Landauer's<sup>75</sup> EMT formula

$$v_A \frac{\sigma_A - \sigma}{\sigma_A + 2\sigma} + v_B \frac{\sigma_B - \sigma}{\sigma_B + 2\sigma} = 0, \qquad (8)$$

which holds for nearly spherical grains of the two phases A and B. If the prerequisites for application of both the EMT equation and the BTE are fulfilled, it follows for the two phases A and B:

$$\sigma_A = \frac{e^2 h^3 L_A}{24 \pi m_A^2} N_A^2(E_{F,A}) \quad \text{for} \quad v_A > \frac{1}{3}, \tag{9}$$

$$\sigma_B = \frac{e^2 h^3 L_B}{24\pi m_B^2} N_B^2(E_{F,B}) \quad \text{for} \quad v_B > \frac{1}{3}, \tag{10}$$

and for nearly free electrons [NFE approximation]

$$\sigma_A = CL_A n^{2/3} \quad \text{for} \quad v_A > \frac{1}{3}, \tag{11}$$

$$\sigma_B = C L_B p^{2/3} \quad \text{for} \quad v_B > \frac{1}{3}, \tag{12}$$

with

$$C = 2\left(\frac{\pi}{3}\right)^{1/3} \left(\frac{e^2}{h}\right). \tag{13}$$

The question of whether and under which conditions the EMT, BTE and NFE approximation can be applied, will be discussed in Secs. IV A and IV B.<sup>76</sup>  $E_{F,i}$ ,  $L_i$ , and  $m_i$  are the Fermi energy, the mean free path, and the effective mass of the carriers in the phase i, respectively. e and h are the elementary charge and Planck's constant, respectively. Equations (9)–(12) hold as long as the phases A and B form infinite clusters through the sample corresponding to  $v_A > 1/3$ and  $v_B > 1/3$ , respectively, as follows from Eqs. (8) and (5). If the phase B does not form an infinite cluster through the whole sample  $(v_B < 1/3)$ , then in the *B* phase grains discrete electronic states are expected with finite energy distances, i.e., electronic transport through the *B* phase grains occurs by tunneling of electrons (temperature T=0), provided  $\sigma_A > 0$ . Analogously, the same is true for the A phase grains, if they do not form an infinite cluster through the sample ( $v_A$ 

<1/3 and  $\sigma_{R}>0$ ). That is why, the M-I transition is decisively determined by the VB, if the M-I transition occurs at  $v_A < 1/3$ . In this case, the resulting *tunneling* conductivity in the A phase,  $\sigma'_A$ , is "metallic" (i.e.,  $\sigma'_A > 0$  at T=0), as long as there are freely propagating carriers in the B phase (corresponding to a *metallic* conductivity in the B phase,  $\sigma_B$ >0 at T=0). Only at disappearance of the *metallic* conductivity in the *B* phase ( $\sigma_B = 0$  at T = 0),  $\sigma'_A$  disappears as well at T=0 because of the additional charging energy of the electrons necessary to be overcome, i.e., for tunneling through an A phase grain, activation becomes necessary  $(\sigma'_A > 0 \text{ only for } T > 0, \text{ if } \sigma_B = 0 \text{ at } T = 0)$ . The situation is analogous to those in cermets or granular metals (Abeles et al.).77-79 In other words, if the M-I transition in alloys with phase separation takes place in the B phase, the M-I transition in the A phase takes place simultaneously (at the same concentration) with the M-I transition in the B phase, if the A phase grains are separated from each other (i.e.,  $v_{A,c} < 1/3$ ;  $v_{A,c} = 1 - v_{B,c}$ ;  $v_{B,c}$  is the volume fraction of the *B* phase at the M-I transition).

# **B.** $N_{1-x}M_x$ alloys

Now let us calculate the hole density in the VB, p, in dependence on concentration. In the phase separated range of an  $N_{1-x}M_x$  alloy, p is given by

$$p = p_0^* - \Delta n - p_{\rm loc} \tag{14}$$

with

$$p_0^* = p_0 - n_B, \tag{15}$$

where  $n_B$  is the own electron density in the *B* phase (i.e., without electron transfer),

$$n_{B} = \mathcal{N}_{B}[(1 - x_{B})Z_{N} + x_{B}Z_{M}], \qquad (16)$$

and  $p_0$  is the theoretically possible density of states available in the VB (i.e., hole density, if all the electrons in the VB are removed).  $p_{loc}$  represents the *loss* of density of states in the VB due to dangling bonds and other structure defects between touching *B* phase grains and within the cores of the *B* phase grains ( $B_0$ ).  $Z_N$  and  $Z_M$  are the valences of the *N* and *M* atoms, respectively, i.e., the number of *s* and *p* valence electrons per *N* or *M* atom which are provided into the CB and VB.  $\Delta n$  is the increase of the electron density in the phase *B* due to electron transfer to the phase *B*, given by

$$\Delta n(\zeta_v) = \frac{n_A - n(\zeta_v)}{\zeta_v},\tag{17}$$

with

$$n_A = \mathcal{N}_A[(1 - x_A)Z_N + x_A Z_M].$$
 (18)

In the equations  $Z_N$  (as  $Z_M$  as well) is assumed to be invariable in the two phases.  $\mathcal{N}_A$  and  $\mathcal{N}_B$  are the atomic densities of the phase A and phase B, respectively.  $n(\zeta_v)$  is the electron density in the phase A and  $\zeta_v$  is related with the *atomic* fractions of the phases A and B,  $X_A$  and  $X_B$ , respectively, by

$$\zeta_{\nu} = \frac{\nu_B}{\nu_A} = \frac{(X_B/X_A)}{(\mathcal{N}_B/\mathcal{N}_A)} \tag{19}$$

and

$$\frac{X_B}{X_A} = \frac{x - x_A}{x_B - x}.$$
(20)

x,  $x_A$ , and  $x_B$  are the *atomic* concentrations of the M atoms in the alloy, the phase A and the phase B, respectively. Applying the microscopical model described in Sec. II A,  $p_0$ , is given by

$$p_0 = 4\mathcal{N}_B \left[ x_B \left( 1 + \frac{X_{B^*}}{X_B} \right) + \frac{\kappa}{4} (1 - x_B) \right].$$
 (21)

Assuming  $\mathcal{N}_B$  is uniform in the whole *B* phase, then

$$X_{B^{*}}/X_{B} = v_{B^{*}}/v_{B}, \qquad (22)$$

and  $p_0$  can be calculated by means of Eqs. (2), (7), (21), and (22) for  $v_B > v_{B,k}$  and  $v_B < 1/3$ , respectively (spherical phase grains). The second term in Eq. (21) takes into account the N atoms solved and assumed to be evenly distributed in the Bphase, where each solved N atom provides  $\kappa$  states to the VB. Since the N atoms provide generally deep lying impurity levels deep in the energy gap,  $\kappa = 0$  can be assumed. With the equations derived we have now the possibility of calculation of the concentration dependence of the conductivity close to the M-I transition on the metallic side, at T=0, where it is to be considered that the electronic conductivity through the A phase grains takes place by tunneling, as  $v_A < 1/3$ , as will be seen later. In the mind of Sec. III A let us apply Eq. (8), where  $\sigma_A$  is replaced by  $\sigma'_A$ , the tunneling conductivity through the A phase grains, and we get for the total conductivity  $\sigma$ 

$$\sigma_B \frac{(3v_B - 1)}{2} \le \sigma \le \sigma_B, \tag{23}$$

since

$$0 \le \sigma'_A \le \sigma_B,\tag{24}$$

i.e., the *tunneling conductivity*,  $\sigma'_A$ , cannot be larger than  $\sigma_B$ . And considering Eqs. (1), (2), and (12)–(23), the upper and lower limit for  $\sigma$  given by Eq. (23), can be calculated for  $v_B > v_{B,k}$ , Eq. (6), for the case of spherical phase grains.

The equations derived hold, on principle, for *crystalline* or *partially crystalline*  $N_{1-x}M_x$  alloys as well, where it is to be considered additionally, that (1) the mean free path is generally significantly larger than the average atomic distance, if the phase considered is crystalline, and (2) the two-phase range is extended between c-N (= A phase) and c-M(N) (= B phase)<sup>61,62</sup> or between c-N and a-M(N),<sup>43,44,65,66</sup> where M(N) means that N atoms are solved in an M matrix.

# a-Au<sub>1-x</sub>Ge<sub>x</sub> alloys

Figure 5 shows for a-Au<sub>1-x</sub>Ge<sub>x</sub> alloys the calculated  $\sigma(x)$  dependence in comparison with experimental  $\sigma$  data at T = 0,  $\sigma(0 \text{ K})$ , and at T=1.5 K,  $\sigma(1.5 \text{ K})$ , taken from Dodson



FIG. 5. Calculated  $\sigma(x)$  dependence close to the M-I transition for *a*-Au<sub>1-x</sub>Ge<sub>x</sub> and comparison with experimental data taken from Dodson *et al.* (see Ref. 66) (flash evaporation); the two calculated  $\sigma(x)$  curves are the upper and lower limit for  $\sigma$  given by Eq. (23), where  $\sigma_B$  is calculated by Eq. (12) in connection with Eq. (14) and Eqs. (1), (2), and (15)–(22).

et al.,66 Figs. 3 and 2 therein, respectively. For the calculations the following physical parameters were applied:  $\mathcal{N}_A$  $=5.8 \times 10^{22} \text{ cm}^{-3}, \ N_B = 5.0 \times 10^{22} \text{ cm}^{-3}, \ d_B = 0.244 \text{ nm}, \ \beta_{\nu}$ =0.8,<sup>27</sup>  $L_B/d_B \approx 1$ ,  $x_A = 0.25$ ,  $x_B = 0.92$ ,  $Z_N = 1$ ,  $Z_M = 4$ ,  $D_A$  $\simeq 1.8$  nm, and  $p_{\text{loc}} \ll p$ . From Eqs. (6), (19), and (20) it follows  $v_{B,k}=0.84$  corresponding to an atomic concentration of  $x_k=0.80$ , i.e., for  $x \leq x_k=0.80$  the  $\sigma$  are calculated a little too big, because  $v_{B^*}/v_B$  calculated by Eq. (2) is too large. The calculations provide  $v_{B,c} = 0.96$  corresponding to  $x_c = 0.89$ , the concentration of the M-I transition. As can be seen in Fig. 5, there are some samples with  $x > x_c$  which are still *metallic* apparently in contradiction to our calculations. This apparent contradiction can, however, be pretended by fluctuations regarding phase grain size and concentration, as will be discussed later. Moreover, the occurrence of additional small Au clusters beside the two phases found by Edwards et al.<sup>29</sup> for a-Au<sub>1-x</sub>Ge<sub>x</sub> films can, possibly, lead to additional differences between calculation and experiment, although in the samples of Dodson et al.66 (deposited at lower substrate temperature compared with those of Ref. 29) no gold clusters larger than 1 nm were found.

The applied  $N_A$  and  $N_B$  parameters are estimated from experimental atomic density data taken from Mangin *et al.*<sup>43</sup>

for the related system *a*-Au-Si;  $x_A \approx 0.25$  is the average composition of the  $\mu$  phase<sup>43,44</sup> and corresponds to a metalloid content typical for relatively stable glassy metals (Nagel,<sup>80</sup> Johnson and Williams<sup>81</sup>).  $d_B$  is set equally to the atomic diameter of the Ge atoms in *c*-Ge. The applied values for  $\beta_v$  (Ref. 82) and  $L_B/d_B$  are got by comparison with other related amorphous alloys to be studied in a separate paper. Although the value for  $\beta_v$  is only a rough estimate, the calculated  $\sigma(x)$  dependence shown in Fig. 5 is relatively insensible against this parameter, because only the concentration range close to the M-I transition is considered. Also the value of  $x_A$ =0.25 has only a very small effect to the result. In Fig. 5, defect states in the *B* phase were neglected (i.e.,  $p_{loc} \ll p$ ). Consideration of these defect states, the curves in Fig. 5 would be shifted in direction to the *x* axis to smaller  $\sigma$ .

#### C. $T_{1-x}M_x$ alloys

The equations derived can be applied to  $T_{1-x}M_x$  alloys as well, if  $Z_N$  in Eqs. (16) and (18), is replaced by  $Z_T$ , the valence of the T atoms, where, however, additional uncertainties come from the facts that  $Z_T$  is not known, generally, and it is to be attended that the electron redistribution includes the d electrons as well. Moreover,  $Z_T$  can be different in the two phases because of the existence of the incompletely occupied d band. Because of the d band influence, Eq. (17) is expected to be modified for  $T_{1-x}M_x$  alloys. In spite of this uncertainty the M-I transition can be described by the above formulae, since in the concentration range close to the M-I transition,  $\Delta n$  is relatively insensible against  $\beta_{rr}$ Another difference to  $N_{1-x}M_x$  alloys is the fact that additional phases are possible in  $T_{1-x}M_x$  alloys (Sec. II), i.e., for description of the M-I transition,  $x_A$  can be essentially larger than in  $a - N_{1-x}M_x$  alloys.

# a-Cr<sub>1-x</sub>Si<sub>x</sub> alloys

Figure 6 shows two calculations for the  $\sigma(x)$  dependence for a-Cr<sub>1-x</sub>Si<sub>x</sub> alloys with different assumed values for the average phase grain size,  $D_A = 1.7$  and 2.3 nm. The system a-Cr<sub>1-x</sub>Si<sub>x</sub> is especially interesting, since it can be considered as an example system for which, on the one hand, there are relatively many experimental data in the scientific literature, and, on the other hand, there are a series of theoretical studies with contrary results. In this connection let us recall at the controvers discussion by Okuma et al.9 and Möbius<sup>83</sup> concerning the different experimental results in comparison to Möbius<sup>15</sup> and their different interpretations (see also Sec. IV C). As already argued in Sec. II, for a-Cr<sub>1-x</sub>Si<sub>x</sub> the two assumed *amorphous* phases are:  $a - \mu$  (phase A) and a-Si (phase B).<sup>59</sup> For the calculations the following physical parameters were applied:  $\mathcal{N}_A = 7.9 \times 10^{22} \text{ cm}^{-3}$ ,  $\mathcal{N}_B = 5.0$  $\times 10^{22} \text{ cm}^{-3}$ ,  $d_B = 0.234 \text{ nm}$ ,  $\beta_v = 0.5$ ,  $L_B/d_B \simeq 1$ ,  $x_A = 0.25$ ,  $x_B = 0.90, Z_{Cr} = 0.5, Z_{Si} = 4, p_{loc} \ll p$ . From Eqs. (6), (19), and (20) it follows for  $D_A=1.7$  nm and  $D_A=2.3$  nm,  $v_{B,k}=0.84$ , and  $v_{B,k}=0.81$  corresponding to  $x_k=0.75$  and  $x_k=0.72$ , and from the calculated  $\sigma(x)$  curves in Fig. 6,  $v_{B,c}=0.97$  corresponding to  $x_c = 0.87$ , and  $v_{B,c} = 0.91$  corresponding to  $x_c$ =0.81, respectively.



FIG. 6. Same as Fig. 5, but for  $a-\operatorname{Cr}_{1-x}\operatorname{Si}_x$ ; comparison of the calculated  $\sigma(x)$  dependence with experimental data taken from Möbius (see Ref. 15) (electron-beam evaporation) and Okuma *et al.* (see Ref. 9) (coevaporation and cosputtering).

The experimental conductivity data close to the M-I transition taken from Möbius<sup>15</sup> are described relatively well by the applied equations, and the enormous difference of the experimental  $\sigma$  data compared with those of Okuma *et al.*<sup>9</sup> can be caused by the different deposition conditions which had led to different phase grain sizes: While the samples of Möbius<sup>15</sup> were realized by evaporation from a Cr-Si alloy ingot, those of Okuma et al.9 were realized by codeposition from two separated sources, a Cr source and a Si one, where concentration gradients about the samples cannot be completely avoided and, consequently, the M-I transition is expected to be "smeared out" over a finite concentration inter*val* characterized by the fact that near  $x_c$  part of the *B* phase is still metallic, whereas another part is already insulating and that the *metallic* fraction of the *B* phase decreases as xincreases.

Nevertheless, the relatively good agreement between the calculated and experimental  $\sigma(x)$  dependence for the Möbius<sup>15</sup> data, as shown in Fig. 6, is surprizing considering the fact that each experimental data point represents another sample of an amorphous alloy for which both small variations in the deposition conditions (substrate temperature, deposition rate, vacuum, ...) and uncertainties of the precise composition of the alloy, *x*, are to be considered. Moreover, the calculations are approximations, where (1) the phase grains were approximated as spheres, (2)  $p_{\text{loc}} \ll p$ , and (3)



FIG. 7. Same as Fig. 5, but for a-Cr<sub>1-x</sub>Ge<sub>x</sub> and comparison of the calculated  $\sigma(x)$  dependence with experimental data taken from Elefant *et al.* (Ref. 87) (electron-beam evaporation).

 $L_B/d_B \approx 1$  was set. The approximation (1) leads to *smaller* values for p (and  $\sigma$ ) in comparison to *nonspheric* B phase grains, for which  $v_{B^*}/v_B$  is larger than given by Eq. (2), whereas the approximation (2) leads to larger values for p (and  $\sigma$ ) and is assumed to play a role only for very small p. The approximation (3) is assumed to be the worse the larger p considering the fact that the mean free path increases with the energy of the carriers<sup>84–86</sup> leading to the fact that the calculated  $\sigma(x)$  curve lies below the experimental  $\sigma$  data, and this difference is expected to increase with increasing p (or  $\sigma$ ). Another uncertainty comes from the assumption that the average phase grain size is independent of x.

From Fig. 6 it can be seen that the concentration, where the M-I transition,  $x_c$ , occurs, depends also on the average metal grain size,  $D_A$ : The larger  $D_A$  the smaller  $x_c$ , if the other physical parameters are constant.

# a-Cr<sub>1-x</sub>Ge<sub>x</sub> alloys

Finally, the calculated  $\sigma(x)$  dependence for a-Cr<sub>1-x</sub>Ge<sub>x</sub> is shown in Fig. 7 in comparison with experimental data taken from Elefant *et al.*<sup>87</sup> which are produced by electron-beam evaporation from ingots of Cr-Ge alloys. The physical parameters applied for the calculations were  $\mathcal{N}_A$ =7.9  $\times 10^{22}$  cm<sup>-3</sup>,  $\mathcal{N}_B$ =5.0 $\times 10^{22}$  cm<sup>-3</sup>,  $d_B$ =0.244 nm,  $\beta_{\nu}$ =0.5,  $L_B/d_B \approx 1$ ,  $x_A$ =0.25,  $x_B$ =0.90,  $Z_{Cr}$ =0.5,  $Z_{Si}$ =4,  $D_A$ =1.4 nm, and  $p_{loc} \ll p$ . From Eqs. (6), (19), and (20) it follows  $v_{B,k} = 0.86$  corresponding to an atomic concentration of  $x_k = 0.77$ , and from the calculated  $\sigma(x)$  curves in Fig. 7,  $v_{B,c} = 0.98$  corresponding to  $x_c = 0.88$ , respectively. As can be seen, the calculated  $\sigma(x)$  dependence describes relatively well the experimental data with the exception of the data point at the largest metal content (x=0.76). Regarding the two data points at x=0.891 we have to consider that the measuring temperature was T=1.9K and that the  $lg(\sigma)-T^{-1/2}$  plots shown by Elefant *et al.*<sup>87</sup> (Figs. 1 and 2 in Ref. 87) have a negative temperature coefficient, and it seems to be not sure whether these samples are still metallic ( $\sigma > 0$  at T=0) or already insulating ( $\sigma=0$  at T=0).

From Eqs. (5), (19), and (20) it follows that  $v_A < 1/3$  is actually fulfilled in the whole concentration ranges considered in Figs. 5–7, i.e., the electronic transport in the *A* phase takes place by tunneling as assumed above (Sec. III A).

The calculations for the amorphous alloys shown in Figs. 5–7 are to be considered as example calculations. The precision of these calculations can be improved, when supplementary to the  $\sigma(x)$  data experimental data for the physical parameters  $x_A$ ,  $x_B$ ,  $D_A$ , and  $\mathcal{N}_A$ ,  $\mathcal{N}_B$  are available, e.g., determined according to the examples of Refs. 31, 32 and 43, respectively. An additional test of the physical model presented can be realized by including measurements of the Seebeck and Hall coefficients in dependence on concentration, which provides the possibility for determination of the electron transfer between the phases and checking Eq. (1).

# **D.** $S_{1-x}M_x$ alloys

In the phase separated range of  $S_{1-x}M_x$  alloys, for calculation of the hole density in the *B* phase, *p*, the equations of Sec. III B can be applied, when  $Z_N$  in Eqs. (16) and (18) is replaced by  $Z_S$ , the valence of the *S*-atoms,

$$n_B = \mathcal{N}_B[(1 - x_B)Z_S + x_B Z_M],$$
 (25)

$$n_A = \mathcal{N}_A[(1 - x_A)Z_S + x_A Z_M],$$
 (26)

and Eq. (21) is replaced by

$$p_0 = 4\mathcal{N}_B \left( 1 - \frac{\nu X_{B^*}}{4 X_B} \right).$$
(27)

 $\nu$  is the number of free  $sp^3$  orbitals per  $B^*$  atom which are not available for the VB caused by the fact that the atoms in the *A* phase (bordering on the  $B^*$  atoms) do not have  $sp^3$ configuration. In analogy to the Davis-Mott model<sup>56</sup> these free  $sp^3$  orbitals (of the  $B^*$  atoms) are assumed to provide a band of localized states in the energy gap of the *B* phase with the density of states

$$p_{\rm loc1} = 2\,\nu \mathcal{N}_B \frac{X_{B^*}}{X_B},\tag{28}$$

which adds to  $2p_{\text{loc}}$  arising from dangling bonds and other structure defects between touching *B* phase grains and within the cores of the *B* phase grains (*B*<sub>0</sub>). In Fig. 8 the calculated carrier densities, *n* and *p*, are shown for Al<sub>1-x</sub>Ge<sub>x</sub> alloys. In



FIG. 8. Calculated carrier densities for  $Al_{1-x}Ge_x$  applying Eq. (14) in connection with Eqs. (15), (17), (19), (20), (22), and (25)–(27) (*two*-phase range  $x_A < x < x_B$ ) and Eqs. (29) and (30) (*one*-phase ranges  $x \le x_A$  and  $x \ge x_B$ , respectively), where  $p_{loc}=0$  and  $\nu = 1$  was set: For  $x_A < x \le 0.5$ , p < 0, i.e., the VB is completely filled and excess electrons occupy surface states on the phase boundaries. Consideration of  $p_{loc} > 0$  shifts the p(x) curve in direction to smaller values.

the *two*-phase-range  $x_A < x < x_B$ , *n* and *p* are calculated with Eqs.  $(1)^{82}$  and Eq. (14) in connection with Eqs. (15), (17), (19), (20), (22), and (25)–(27), where  $v_{B^*}/v_B$  is calculated by Eqs. (2) and (7) for  $v_B < 1/3$  and  $v_B > v_{B,k}$ , respectively, and linearly interpolated (relating to  $x_B$ ) in the concentration range  $1/3 < v_B < v_{B,k}$  with  $v_{B,k}$  followed from Eq. (6). For the physical parameters the following values are applied:  $\mathcal{N}_A$  $=6.0 \times 10^{22} \text{ cm}^{-3}, \ \mathcal{N}_B = 5.0 \times 10^{22} \text{ cm}^{-3}, \ d_B = 0.244 \text{ nm}, \ \beta_{\nu}$ =1.3,<sup>27</sup>  $D_A \simeq D_B \simeq 5$  nm,  $x_A = 0.05$ ,  $x_B = 0.56$ ,  $Z_S = 3$ ,  $Z_M = 4$ ,  $p_{\rm loc}=0$ , and  $\nu=1$ . The value for  $x_B$  in the two-phase range is determined from the free enthalpy diagram for Al-Ge by Köster<sup>88</sup> (tangent construction). The value for  $\beta_{\nu}$  was estimated from  $\sigma(x)$  data measured at T=5 K published by McLachlan et al.<sup>70</sup> applying EMT and Eqs. (11) and (32) under the assumption of  $L_A \simeq D_A$  [crystalline Al(Ge) grains] and consideration of tunneling contribution through the Bphase (to be studied in a separate paper).<sup>89</sup> In the one-phase ranges the carrier densities are calculated applying

$$n = \mathcal{N}_A[(1-x)Z_S + xZ_M] \tag{29}$$

for  $x \leq x_A$  and

$$p = \mathcal{N}_B[4 - (1 - x)Z_S + xZ_M] - p_{\text{loc}}$$
(30)

for  $x \ge x_B$ .  $x_c$ , the concentration of the M-I transition, stated by McLachlan *et al.*,<sup>70</sup> and the assumed values for  $x_A$  and  $x_B$ are also drawn in Fig. 8. Since we are interested in the basical tendency,  $p_{loc}=0$  is set for the calculation of p(x) in Fig. 8.

As can be seen in Fig. 8, two principle problems arise.

(a) The calculated hole density, p, results to be negative for  $x \leq 0.5$ , since the amount of transferred electrons described by Eq. (1) is larger than the number of electronic states available in the VB for x essentially smaller than  $x_B$ . The amount of p increases with decreasing x.

(b) For  $x > x_c$ , but x near to  $x_B$ , the Al<sub>1-x</sub>Ge<sub>x</sub> alloys are electrically insulating, although p is essentially larger than zero.

Problems (a) and (b) also continue, if the assumed values for  $D_A$ ,  $D_B$ ,  $x_A$ ,  $x_B$ ,  $\nu$ , and  $\beta_{\nu}$  are changed within the scope of physically reasonable values. The second problem, (b), can be asigned to the neglection of  $p_{\rm loc}$ , since a nonzero  $p_{\rm loc}$ shifts the p curve in direction to smaller p values. However, if so, then there is not yet an answer on the first problem, (a). Reason is the assumption made until now, that both the A and B phase grains are spherical. This assumption is apparently not true, generally, for S-M alloys. This fact corresponds with the granular structure<sup>69,70,72,73,90</sup> found experimentally for Al-Ge films on the metallic side, where nearly spherical grains are only formed by the metallic phase (phase A), whereas the phase B forms very thin Ge(Al) mantle surrounding the metallic grains (modified physical model) leading to a very increased boundary face regarding the *B* phase providing additional electronic states for acceptance of electrons transferred from the A phase. For such a microscopic structure the sum of all the boundary faces between the two different phases is considerably increased in comparison to a structure with *spherical* phase grains for *both* the phase A and phase B. In other words, the electron redistribution between the two phases affects the microscopic structure of the alloy as well.

Considering a single (spherical) *A* phase grain with the diameter  $D_A$  completely enveloped by a *B* phase coating which has the (constante) thickness  $\delta_B$ , then it follows for  $\delta_B \ll D_A$ :

$$D_A = \frac{2\,\delta_B}{\left(v_B^*/v_A + 1\right)^{1/3} - 1}.\tag{31}$$

If  $\delta_B = d_B$  (i.e., the *B* phase barrieres between two "touching" *A* phase grains has a thickness of *two* atomic monolayers),  $X_{B0} = v_{B0} = 0$ , and with Eqs. (4), (5), and (31) we get

$$D_A = \frac{2d_B}{v_A^{-1/3} - 1}.$$
 (32)

In Fig. 9 the dependence of  $D_A$  on x described by Eq. (32) is drawn, where  $v_A$  is replaced by



FIG. 9. Dependence of the average phase grain size,  $D_A$ , on x for g-Al<sub>1-x</sub>Ge<sub>x</sub> calculated by Eqs. (32) and (33) for the *modified physical model*, where thin Ge(Al) mantle with the thickness of  $2d_B$  is surrounding the spherical *metallic* Al(Ge) grains.

$$v_{A} = \left[1 + \frac{\mathcal{N}_{A}}{\mathcal{N}_{B}} \frac{(x - x_{A})}{(x_{B} - x)}\right]^{-1}.$$
 (33)

The concentration dependencies of both "p(x)" and  $D_A(x)$  drawn in Figs. 8 and 9, respectively, are very well reflected by experimental results of as-deposited Al<sub>1-x</sub>Ge<sub>x</sub> films published by Lereah *et al.*,<sup>73</sup> McLachlan *et al.*,<sup>70</sup> Rosenbaum *et al.*,<sup>42</sup> and Catalina and Afonso.<sup>72</sup>

(1) On the insulating side  $(x > x_c)$ , both the Ge and the Al components (phases) are found to have amorphous structure. This finding corresponds with Fig. 8: *charged* phase grain faces (prerequisite for *granular* structure) are not yet or hardly formed, because |p| is small. On the metallic side ( $x < x_c$ ), *granular* Al grains embedded in an amorphous matrix are found: reason are the *charged* phase boundary faces, because p < 0 and |p| is large, Fig. 8.

(2) On the insulating side  $(x>x_c)$ , the (*amorphous*) Al grains are found to be smaller than <2 nm, whereas, on the metallic side  $(x<x_c)$ , the (*granular*) Al grains rapidly increase to 10–20 nm, in correspondence with the semiquantitative consideration, Fig. 9.

(3) The M-I transition takes place at relatively large metal content ( $x_c$ =0.56). The reason is the fact that the VB does not contribute to the electronic transport, since completely occupied (at *T*=0) and, as a consequence, the M-I

transition takes place, if the *A* phase does no longer form an infinite cluster through the specimen. With increasing *x* (or  $v_B$ ), the probability for interruption of the infinite *A* phase cluster increases, and for the special laminared *B* phase structure this interruption is expected to occur at relatively small *x* (or  $v_B$ ). We assume that, for small *x*, the *B* phase covers do not *completely* cover the *A* phase grains, but that there are *A*-*A* phase grain contacts, which are the prerequisite for an infinite *A* phase cluster.<sup>91</sup> If an infinite *A* phase cluster does no longer exist, tunneling of electrons through the *B* phase films does not lead to a metallic conductivity (characterized by  $\sigma > 0$  at T=0) because of the charging energy to be overcome between different *A* phase grains. The situation is comparable with those in cermets described by Abeles *et al.*<sup>77-79</sup>

Within the *modified physical model* the density of states in the laminared *B* phase results for  $\delta_B = d_B$ :

$$p_0 = 4\mathcal{N}_B \left(1 - \frac{\nu}{4}\right) \tag{34}$$

and

$$p_{\rm loc1} = 2\nu \mathcal{N}_B \tag{35}$$

following from Eqs. (27) and (28), respectively, for  $X_{B0} = v_{B0} = 0$ . In sum, for all the electrons in the *B* phase, the own electron density,  $n_B$ , Eq. (25), and the transferred one,  $\Delta n$ , Eq. (17), there are below the conduction band of Ge(Al)

$$p_0 + p_{\text{loc1}} = 4\mathcal{N}_B \left(1 + \frac{\nu}{4}\right) \tag{36}$$

electronic states per volume unit, which for  $\nu = 1$  is  $\approx 25 \times 10^{22}$  cm<sup>-3</sup>, and comparing with Fig. 8, in the concentration range  $x > x_A$ ,  $p_0 + p_{loc1} > n_B + \Delta n$ , generally. Only for very small *x* (but  $x > x_A$ ),  $p_0 + p_{loc1}$  is nearly comparable with  $n_B + \Delta n$  corresponding to an average number of  $\approx 5$  electrons per  $B^*$  atom. This estimation is to be considered as temporary, as it depends sensibly on the value for  $\beta_v$  applied.<sup>89</sup> Replacing Eq. (27) by Eq. (34), p < 0 for the complete *two*-phase range, i.e., metallic conductivity in the VB ( $\sigma_B > 0$  for T=0) is not expected for  $x_A < x < x_B$  [problem (b) mentioned earlier]. And in the *one*-phase range  $x \ge x_B$ , metallic conductivity does also not occur because of  $-p_{loc}$  (arising from dangling bonds and other structure defects) (Ref. 92) shifting the p(x) curve into direction of negative values.

Summarizing, the experimental findings, granular structure for large metal content, but amorphous structure for small metal contant, rapid decrease of the average metal grain sizes with increasing x (or  $v_B$ ), and relatively small  $x_c$ , follow informely from the *modified physical model* described.

The *modified physical model* can also be basis for a model of the class of cermets<sup>77,79</sup> for which both the *granular* structure and decrease of the metal grain size with decreasing metal content are characteristic features (see, e.g., Abeles *et al.*,<sup>77</sup> Figs. 13–16, 17, and 19 therein).

Comparing  $S_{1-x}M_x$  alloys with  $N_{1-x}M_x$  alloys, a crucial difference consists in the fact that in the latter each  $B^*$  atom in the M(N) phase (*B* phase) provides eight electronic states

to the VB (2 s, 3 bonding p states, and 3 antibonding p states), whereas in the case of  $S_{1-x}M_x$  alloys each  $B^*$  atom provides only 4- $\nu$  electronic states to the VB. Another difference is the fact that in  $N_{1-x}M_x$  alloys, there are d-p bondings at the interfaces between the different phases, whereas in  $S_{1-x}M_x$  alloys d-p bondings are absent, i.e., bonding between the different next-neighbored phase ranges (A and B) in  $S_{1-x}M_x$  alloys is essentially determined by *Coulomb attraction*, whereas in  $N_{1-x}M_x$  alloys band structure energy arising from the d-p bondings plays an additional role.

Regarding the incompletely occupied VB, in  $a - T_{1-x}M_x$  alloys the situation is expected to be comparable with those in  $a - N_{1-x}M_x$  alloys, however, with the difference that the M-I transition can take place between other phases (Sec. II A) than in  $a - N_{1-x}M_x$  alloys. In  $c - N_{1-x}M_x$  and  $c - T_{1-x}M_x$  alloys the situation is, on principle, expected to be comparable with those in  $a - N_{1-x}M_x$  and  $a - T_{1-x}M_x$  alloys, however with the differences described in Sec. II A.

Although in random  $S_{1-x}M_x$  alloys  $(r-S_{1-x}M_x)$  the M-I transition occurs at relatively large metalloid content, an incompletely occupied VB is, nevertheless, inprobable in these alloys; reason for such large  $x_c$  (or  $v_{B,c}$ ) is suggested to be caused by the clefted "fjord"-like or "fractal" structure<sup>73</sup> realizing a possiblest large surface of the phase boundary for acceptance of all the transferred electrons for which in the VB there are not a sufficient number of electronic states. Typical for such а "fractal" structure in r-Al-Ge are "Al-Ge colonies" (Lereah et al.<sup>73</sup>) where Ge crystals with a dense branching morphology are completely surrounded by a rim of Al-rich single-crystal matrix which acts as large metallic grains, although each of these large metallic grains contain a considerable volume fraction of the non metallic phase. Such a "fjord"-like or "fractal" structure growing by annealing of  $g-S_{1-x}M_x$  alloys, has been intensively studied by Lereah et al.,<sup>73</sup> see, e.g., Figs. 1 and 6 of Ref. 73.

# **IV. DISCUSSION**

# A. EMT

The EMT and their results are often considered to be suspect,<sup>77,93</sup> especially for description of the M-I transition for which the EMT and percolation theory provide different volume fractions of the metallic component embedded in an insulting matrix: "0.15" following for the percolation threshold94 determined by a Monte Carlo sampling of disordered three-dimensional resistor networks and "1/3" following from the EMT, Eq. (8). This difference between the percolation theory and the EMT was in the past one reason for a reservation against the EMT which is considered to be "unreliable in the transition region  $C \le 0.4$  and below" (Ref. 93, C corresponds to our  $v_A$ ), and consequently also for describing the M-I transition. A second reason for this reservation against the EMT were considerable differences between the predictions by the EMT and the experimental results to both the concentration dependence of the conductivity,  $\sigma(x)$ , and the concentration of the M-I transition,  $x_c$ , in cermets (see, e.g., Ref. 77, Fig. 19 therein).

In spite of this reservation, we expect that the EMT provides for metal-metalloid alloys a more realistic description for the transport properties (also near to the M-I transition) than the percolation theory because of the following reasons.

(1) In real disordered alloys the occupation of the "sites" by the A and B phase grains does not occur completely accidentally or randomly: in the next neighborhood of an A phase grain the probability for finding of B phase grains is larger than it would be, when the A and B phase grains would be completely accidentally distributed in the alloy as assumed in the percolation theory. The reason is the fact that in the two-phase region the average composition of the surrounding of this A phase grain tends away from the average composition of the alloy into the direction of the B phase composition. Vice versa, in the surrounding of a *B* phase grain the composition tends rather into the direction of the A phase composition. Therefore, the interrupt of an infinite cluster of connected A phase grains through the sample is shifted to a larger volume fraction of the metallic component in comparison to an completely accidental arrangement of the phase grains. From this point of view, the EMT prediction for the interrupt of an infinite A phase cluster at  $v_A$ =1/3 seems to be rather probable than the percolation theory prediction,  $v_A = 0.15$ .

(2) Regarding granular metals or cermets, the considerable differences between experiment and the EMT predictions quoted earlier<sup>77</sup> can often be caused by the simple assumption made that  $x=X_B$  which is not true in many cases, since the insulating component can contains a considerable fraction of metal atoms,<sup>95</sup> and also the metallic component can contain a considerable fraction of metalloid atoms. Regarding  $a - N_{1-x}M_x$  or  $a - T_{1-x}M_x$  alloys we recall at the result of Sec. III that the M-I transition must not be determined by interrupt of a "metallic" phase, because in the phase separated range, the phase *a*-Si or *a*-Ge can be *metallic* as well depending on the amount of the electronic states arising from the internal surfaces  $(B^*)$  and their occupation by electrons leading to the fact that the M-I transition in these systems occurs at concentrations essentially different from x=1/3 (or more precise  $v_A = 1/3$ ). Because of these reasons, we assume that the EMT provides a more realistic description of the electrical properties of disordered alloys with phase separation than any percolation description.

#### **B. BTE and NFE approximation**

Today, there is a general consensus that:

(a) *NFE approximation* is not an appropriate method for description of the electrons in strongly scattering systems as, e.g., metal-metalloid alloys. This point of view has been hardened after in the past "the great majority of experimental papers have attempted to explain the data by an uncritical application of nearly free electron (NFE) ideas" (Howson and Gallagher).<sup>96</sup> The same point of view has been also consolidated regarding the

(b) *BTE:* when the mean free path of the carriers, *L*, becomes comparable with the average atomic distance, *d*, the wave number *k* is no longer a good quantum number for describing the eigenstates and the *BTE* cannot be applied.<sup>16,17</sup>

Now we shall show that consideration of phase separa-

*tion* in disordered metallic alloys can lead to an alternative point of view. We give two arguments, a theoretical argument and an experimental example.

Historically seen, view (b) cited earlier was concluded from the fact that in metals<sup>97</sup>

$$k_F \simeq \frac{\pi}{d},\tag{37}$$

where  $k_F$  is the wave number at the Fermi surface. Inserting Eq. (37) and measured  $\sigma$  data of any metal-metalloid alloy on the metallic side, but close to the M-I transition, in the BTE:

$$\sigma = \frac{S_F e^2 L}{6\pi^2 h},\tag{38}$$

and assuming a spherical Fermi surface  $S_F=4\pi k_F^2$ , then it follows L < d, which is physically not possible, because the average free path cannot be smaller than the average distance of the scattering centers. However, considering phase separation, with decreasing fraction of the "metallic" phase (in the two-phase range), Eq. (37) is no longer valid and Eq. (38) is to be applied to the two phases separately, where each phase has its "own" Fermi surface, if  $v_A > 1/3$ ,  $v_B > 1/3$ (Sec. III A). And the carrier densities in the two phases are essentially different from a situation corresponding to Eq. (37).

Since the electron density in the metallic phase decreases with increasing x (or with increasing  $\zeta$ ),  $k_F$  in the phase A decreases as well according to

$$k_F = (3\pi^2 n)^{1/3} \tag{39}$$

(spherical Fermi surface and NFE approximation). For the hole density *p* in the phase *B*, the situation is analoguous, because *p* decreases with increasing *x* as well (*N*-*M*, *T*-*M* alloys, see Secs. II and III). This leads to the fact that application of the BTE in NFE approximation and  $\sigma(x)$  data for any metallic alloy remains compatible with the condition " $L \ge d$ " even near the M-I transition.

Experimental example: Mizutani and Yoshida<sup>98</sup> have shown for a-(AgCu)<sub>1-x</sub>Ge<sub>x</sub> alloys that for x < 0.3 there is a good agreement between the measured Hall coefficient data,  $R_H$ , and the free-electron values

$$R_{H0} = (en_0)^{-1} \tag{40}$$

derived from the BTE in NFE approximation, where  $n_0$  is the total valence electron density in the alloy [Eq. (8) of Pap. I] This agreement between  $R_H$  and  $R_{H0}$  gives the justification for application of the BTE in NFE approximation to the *conductivity* for x < 0.3 as well. Applying Eq. (11) to the measured  $\sigma$  data<sup>98</sup> of a-(AgCu)<sub>1-x</sub>Ge<sub>x</sub> for x < 0.3, where  $\sigma_A = \sigma$  (one-phase range), it follows that  $L \simeq d$  for 0.2 < x < 0.3.<sup>74</sup> In other words, in the concentration range 0.2 < x < 0.3 the BTE in NFE approximation for the Hall coefficient, although  $L \simeq d$  is already reached. This is in contradiction to the view that  $k_F$  is no longer a good quantum number, since L is comparable with d.

With these two arguments, and in agreement with the alternative concept of Pap. I, we propose an *alternative inter*- pretation: L cannot be smaller than d; therefore in disordered electronic systems, d is the lower limit for L, and k can be considered as a good quantum number for describing the eigenstates, as long as

$$kL > c^*, \tag{41}$$

where  $c^*$  is of the order of 1 (Ref. 99) (Ioffe-Regel criterion). The decisive difference to the point of view (b) cited earlier is the fact that (independent of the degree of disorder represented by the mean free path L) the electronic states can be extended for connected ranges of the same phase, and the concept of a Fermi surface is after all applicable, as long as Eq. (41) is fulfilled, even for  $L \simeq d$ . Considering the experimental example a-(AgCu)<sub>1-x</sub>Ge<sub>x</sub>, the abrupt splitting between  $n_0$  and  $n_H = (eR_H)^{-1}$  at  $x \approx 0.3$  is a consequence<sup>74</sup> of the beginning phase separation for  $x \ge 0.3$ , because only still part of the total electron density is available in the phase A due to the electron redistribution to the second phase [Eq. (1)]. On the other hand, in granular metal-metalloid alloys (Sec. III D) on the metallic side the Fermi level lies in ranges of trap states in the phase B, however, in ranges of extended states in the phase A.

For consideration of the electronic transport processes in a phase at T=0 we concentrate our attention to  $k_F$ :

$$k_F > \frac{c^*}{L}.\tag{42}$$

For the case when scattering is strong, *L* can approach *d*, but cannot be smaller than *d*, and with Eq. (42) it follows a lower limit, where  $k_F$  still can be applied for description of the wave functions of the carriers at the Fermi surface, given by

$$k_F \gtrsim \frac{c^*}{d},\tag{43}$$

if  $L \simeq d$  is realized.  $k_F$  in Eqs. (42) and (43) is limited to continuous range of atoms with overlapping wave functions. Outside of this range the wave functions decrease exponentially. Now let us consider the question of whether and under which conditions the BTE and NFE approximation can be applied for disordered alloys with phase separation. The decrease of n with increasing x or  $\zeta$  [Eq. (1)] leads also to decrease of the Fermi energy,  $E_F$ , in the phase A, and the corresponding Fermi surface approaches a spherical form also in *crystalline* alloys, the smaller *n*, approaching a NFE behavior, since the Fermi surface for phase A is sufficiently distant to the first Brillouin zone boundary, when n is sufficiently small. The situation in phase B is similar regarding the hole density p for sufficiently large  $v_B$ , where p is small (see Secs. II and III). This is especially so near to the M-I transition, provided Eq. (42) is still fulfilled.

#### C. Minimum metallic conductivity

Because of Eq. (42)—in connection with Eq. (39)—there exists a lower limit for *n*, below it extended electronic states cannot be exist. Regarding Eq. (42), in the literature different values<sup>99</sup> for  $c^*$  are given ranging from  $1/2\pi$  until  $\pi$  which differ by a factor of 20 corresponding to a factor of 4 orders

of magnitude for *n* according to Eq. (39), and because of this large span for *n* the question of the lowest possibly limit of  $k_F L$  becomes importantly. From Heisenberg's uncertainty principle it follows  $c^*=1/4$  (see the Appendix) and we define this value as the lowest possibly limit where extended electronic states still can exist. When *n* decreases below  $n_{crit}$  given by

$$n_{\rm crit} = \frac{1}{3\pi^2} \left(\frac{c^*}{L}\right)^3,\tag{44}$$

corresponding to a minimum metallic conductivity

$$\sigma_{\min} \simeq \frac{c^*}{6} \left(\frac{e^2}{h}\right) \frac{1}{L},\tag{45}$$

latest then localization in the metallic phase of a disordered alloy must occur. Equations (44) and (45) result from Eqs. (11), (39), and (42). For strong scattering characterized by  $L \simeq d \simeq 0.25$  nm it follows from Eqs. (44) and (45):

$$n_{\rm crit} \simeq 3 \times 10^{19} \,{\rm cm}^{-3}$$
 (46)

and

$$\sigma_{\min} \simeq \frac{c^*}{6} \left(\frac{e^2}{h}\right) \frac{1}{d} \simeq 20 \ \Omega^{-1} \,\mathrm{cm}^{-1}.$$
 (47)

For a nearly completely filled band the same equations, Eqs. (41), (43), (45), and (47), hold, where *L* has the meaning of the mean free path of the holes at the Fermi energy of the nearly completely filled band, and for the critical hole density it follows:

$$p_{\rm crit} = \frac{1}{3\pi^2} \left(\frac{c^*}{L}\right)^3,$$
 (48)

which for strong scattering, i.e.,  $L \simeq d \simeq 0.25$  nm, again leads to

$$p_{\rm crit} \simeq 3 \times 10^{19} \,{\rm cm}^{-3}.$$
 (49)

The first equation of Eq. (47) looks like the original relation for a minimum metallic conductivity derived by Mott with  $c^*/6 \simeq 0.026 \cdot 2\pi$  (Ref. 16, p. 30), where additionally the disorder effect by random potentials was considered. The difference consists in the fact that for the derivation of Eqs. (44), (45), and (48) random atomic potentials within a single phase are not assumed. In other words, we cannot see any reason for the assumption that in one of the two phases of an alloy with phase separation there would be essential potential fluctuations growing with increasing  $v_B$  from  $v_B=0$  to larger values until  $v_{Bc}$  (the *B* phase fraction at the M-I transition) or beyond it. The disorder effect on the electronic transport properties can be characterized alone by the "ordering parameter" L, and, if  $L \simeq d$  is already realized,  $\sigma$  at T=0 decreases (with increasing  $v_{\rm R}$ ) not by further increasing "disorder," but by decrease of *n* or/and *p* according to the formulae of Secs. II and III.

The conclusion of a minimum metallic conductivity  $\sigma_{\min}$  seems to be in contradiction to the conclusion by Okuma *et al.*<sup>9</sup> and Hertel *et al.*,<sup>8</sup> that the M-I transition in a-Cr<sub>1-x</sub>Si<sub>x</sub> and a-Nb<sub>1-x</sub>Si<sub>x</sub> occurs continuously and that for  $T \rightarrow 0$ , es-

sentially smaller  $\sigma$  were measured than 20  $\Omega^{-1}$  cm<sup>-1</sup>. This finding is, however, not really in contradiction considering the fact that the samples are produced by coevaporation<sup>9</sup> and cosputterring<sup>8,9</sup> from two locally *separated* sources, one with the element Cr or Nb and the other with the element Si, and in the samples a concentration gradient is to be expected. If there is a concentration gradient perpendicularly to the direction of the measuring current for measurement of  $\sigma$ , then a continuous M-I transition with increasing (average) x can be pretended, because the sample occurs to be *metallic* as long as there is still a narrow *metallic* current path through the sample. A concentration gradient is connected with a gradient of  $\zeta$  and leads, therefore, also to a gradient of p (according to the equations of Secs. II and III). Immediately at the M-I transition locally limited *metallic* ranges  $(p > p_{crit}, \sigma)$ >0 at T=0) and locally limited *insulating* ranges ( $p < p_{crit}$ ,  $\sigma=0$  at T=0) can coexist leading to an *average*  $\sigma < \sigma_{\min}$  at T=0, i.e., the M-I transition can be smeared out across a concentration *range* and the resulting conductivity at T=0can be smaller than given by Eqs. (45) and (47) caused by the "dilution" of the metallic fraction within a phase. As long as there is still a connected cluster of *metallic* ranges (of the same phase) through the whole sample, this sample shows *metallic* conductivity ( $\sigma > 0$  at T=0). Moreover, we have to take into account that L can be larger than d (for instance in *crystalline* alloys) corresponding to a smaller  $\sigma_{\min}$  according to Eq. (45) compared with Eq. (47).

Möbius *et al.* concluded from phenomenological considerations of conductivity data of  $a-Ni_{1-x}Si_x$  (Ref. 10) and  $a-Cr_{1-x}Si_x$  (Refs. 11–15) that the M-I transition is very likely discontinuous at T=0. This conclusion corresponds with our result of a minimum metallic conductivity in a metallic phase.

#### D. Mobility edges and comparison with photoelectron spectra

For a nearly empty parabolic band in NFE approximation, the density of states is given by  $N(E)=4 \ mk/h^2$ , and replacing k by Eq. (41)—it follows for the density of states at the mobility edge,  $E_C$ :

$$N(E_C) = \frac{4c^*m}{h^2 L},$$
 (50)

and for the energy at the mobility edge,  $E_C$ :

$$E_C = E_A + \frac{(c^*\hbar/L)^2}{2m},$$
 (51)

where *m* is the effective electron mass,  $E_A$  characterizes the bottom of the band.

For a nearly filled parabolic band in NFE approximation it follows for the density of states at the mobility edge,  $E_V$ :

$$N(E_V) = \frac{4c^*m}{h^2 L},$$
 (52)

and for the energy at the mobility edge,  $E_V$ :

$$E_V = E_B - \frac{(c^* \hbar/L)^2}{2m},$$
 (53)

where *m* and *L* have the meaning of an effective mass and mean free path of the holes at the Fermi energy of the nearly filled band.  $E_B$  characterizes the top of the band.

For the case of strong scattering, in Eqs. (50)–(53), L is to be replaced by d. For any (nonparabolic) band, Eqs. (51) and (53) no longer have a physical meaning in this context and we apply the terms  $E_C$  and  $E_V$  only to characterize the points on the energy scale, where N(E) crosses a mobility edge defined by Eqs. (50) and (52). In other words, Eqs. (50) and (52) can be applied to define mobility edges also for any (nonparabolic) band, provided effective masses can be defined according to

$$\frac{1}{m} = \frac{1}{\hbar^2} \frac{\partial^2 E}{\partial k^2} \tag{54}$$

with a defined E(k) dependence for  $kL > c^*$ , Eq. (41), in accordance with the *alternative interpretation* proposed in Sec. IV B.

Applying the discussion of Sec. III, the M-I transition in an  $a - N_{1-x}M_x$  or  $a - T_{1-x}M_x$  alloy takes place, when p decreases below  $p_{crit}$ , Eqs. (48) and (49), provided  $v_{A,c} < 1/3$ , or, within the density of states picture: When the Fermi level  $\mu$  lies beyond  $E_V$ , then the corresponding *metallic* conductivity in the phase disappears,  $\sigma=0$  at T=0. The finding of a finite electronic specific heat coefficient  $\gamma$  beyond the M-I transition in a-Mo<sub>1-x</sub>Ge<sub>x</sub>,<sup>33,34</sup> a-Au<sub>1-x</sub>Si<sub>x</sub>,<sup>35</sup> a-V<sub>1-x</sub>Si<sub>x</sub>,<sup>36</sup> and  $a-\text{Ti}_{1-x}\text{Si}_x$  (Ref. 37) quoted in Sec. I, can be caused by the *finite* hole density p in the VB [0 $0 < N(\mu) < N(E_V), v_B > v_{B,c}; N(\mu)$  is the density of states at  $\mu$ ]. In the case of a-V<sub>1-x</sub>Si<sub>x</sub>, Mizutani *et al.*<sup>36</sup> found also from x-ray photoelectron spectroscopy (XPS) valence band spectra, "that the density of states at the Fermi level is definitely finite even in the insulating regime," although precipitation of V clusters is absent in the  $a-V_{1-x}Si_x$  samples,<sup>36</sup> i.e.,  $\sigma=0$  at T=0, although the density of states at the Fermi level  $\mu$  is finite, corresponding with our interpretation that for the insulating side 0 corresponding to 0 $< N(\mu) < N(E_V)$ .

High-resolution photoemission (XPS and ultraviolet photoelectron spectroscopy) spectra profiles near the Fermi level for amorphous alloys<sup>23,36,65,100-102</sup> show a band *profile* around the Fermi edge  $\mu$ , where above a critical metal content,  $1-x_m$ ,  $N(\mu)$  increases with increasing metal content, 1-x:<sup>103</sup> *a*-Ti<sub>1-x</sub>Si<sub>x</sub> (Kawade *et al.*,<sup>23</sup> Fig. 7 therein), a-Pd<sub>1-x</sub>Ge<sub>x</sub> (Suzuki *et al.*,<sup>101</sup> Fig. 3 therein), a-Ag<sub>1-x</sub>Ge<sub>x</sub> (Suzuki *et al.*,  $^{65}$  Fig. 3 therein), a-Ni<sub>1-x</sub>Si<sub>x</sub> (Isobe *et al.*,  $^{100}$  Fig. 6 therein),  $a-V_{1-x}Si_x$  (Mizutani et al.,<sup>36</sup> Fig. 14 therein), a -Pd<sub>1-r</sub>Si<sub>r</sub> (Tanaka et al.,<sup>102</sup> Fig. 6 therein). This band profile near  $\mu$  corresponds with our VB superimposed by the d states of the metal atoms forming bonds<sup>60</sup> with the p states of the M atoms. The increase of the hole density p with decreasing x (corresponding with the increase of  $\sigma$  in Figs. 5–7) corresponds with the increase of  $N(\mu)$  in the band profile.

The values for  $(1-x_m)$  resulting from the spectra are relatively small, where phase separation in the alloy is surely not yet realized:  $1 - x_m \approx 0.013$  for  $a - \text{Pd}_{1-x}\text{Ge}_x$ .<sup>101</sup>  $1 - x_m \approx 0.04$ for  $a - \text{Ti}_{1-x}\text{Si}_x$ .<sup>23</sup>  $1 - x_m \approx 0.056$  for  $a - \text{Ag}_{1-x}\text{Ge}_x$ .<sup>65</sup>  $1 - x_m \approx 0.07$  for  $a - \text{Ni}_{1-x}\text{Si}_x$ .<sup>100</sup> and  $a - \text{V}_{1-x}\text{Si}_x$ .<sup>36</sup> Only for  $a - Pd_{1-x}Si_x$ , <sup>102</sup>  $1 - x_m \approx 0.12$  is assumed to be in the two-phase region. The finding that  $1-x_m$  lies in the one-phase region, is not in contradiction to our interpretation: in the one-phase region  $(x > x_B)$  the N or T atoms solved in the *a*-M-matrix provide electrons which occupy the band tail (arising from defect states) on the top of the valence band of a-M. With increasing metal content solved, the valence electron concentration decreases, since the N or T atoms do contribute essentially fewer electrons per atom to the VB than the host Matoms, i.e., the Fermi level moves into direction to larger density of states (within the upper valence band tail) corresponding to an increase of  $N(\mu)$  with decreasing x. As long as  $N(\mu) < N(E_V)$ ,  $\sigma = 0$  at T = 0, i.e., the samples are insulating, although  $N(\mu) > 0$ . With beginning of the two-phase situation ( $x \le x_B$ ) the states with the  $s^2 p^2$  orbital configuration of the  $B^*$  atoms add to the valence band (now VB, phase separated region), and  $N_B(\mu)$ , the density of states in the B phase at  $E = \mu$ , increases. Note that the measured density of states is a superposition of the contributions of the two phases,  $N_A(E)$  and  $N_B(E)$ , where near to  $x_c$  those of the B phase dominates. The M-I transition occurs, when  $\mu$  crosses the mobility edge corresponding to  $N(\mu) = N(E_{\nu})$ . The increase of  $N(\mu)$  [or more precise  $N_B(\mu)$ ] with decreasing x is reduced by the electron transfer realizing a common Fermi level  $\mu$  for the whole sample.

In Eq. (14) the upper band tail of the VB (above  $E_V$ ) is considered indirectly by the introduction of  $p_{loc}$  which is subtracted from the total hole density in the VB.

#### **V. SUMMARY**

The conclusions *amorphous phase separation* (i) and *band separation* (ii), where the carriers can be freely propagating and the corresponding wave functions are extended with respect to connected phase ranges, drawn in Pap.I for amorphous transition-metal-metalloid alloys, are now confirmed or supported by experimental and theoretical results by independent authors. *Conclusion* (iii), *electron redistribution (electron transfer) between the phases* [Eq. (1)] is not yet confirmed by independent authors.

Because of this confirmation and support of the *conclusions* (i) and (ii), the *amorphous phase separation model* developed in Pap. I, is extended to  $N_{1-x}M_x$ ,  $T_{1-x}M_x$ , and  $S_{1-x}M_x$  alloys: Phase separation in two phases with different SRO (i) leads to band separation (ii) in two electronic bands, the CB constrained to phase A, and the VB constrained to phase B. B is the phase with the deeper average potential. The electronic transport in the phase separated regime is determined by both the *local band structure* in the different phases and the *electron distribution* between the phases, where (1) the internal surfaces (phase boundaries), (2) the average compositions of the two phases,  $x_A$  and  $x_B$ , and (3) electron redistribution (electron moving through the alloy is

*not restricted to a single phase*, but it can overcome the phase boundaries, provided both the CB and the VB are incompletely occupied.

Considering valence band spectra it is assumed that for  $a - N_{1-x}M_x$  and  $a - T_{1-x}M_x$  alloys, in the two-phase range between a-Si or a-Ge (=phase B) and the next amorphous phase (=phase A), the VB consists essentially of bonding p and antibonding p states (from B atoms at the A/B boundary faces called  $B^*$  atoms) and of bonding  $sp^3$  states (from *core* atoms of the *B* phase grains called  $B_0$  atoms), Figs. 1 and 2, and for the VB generally hole conductivity is expected, because both a considerable part of the antibonding p states and the bonding  $sp^3$  states are below the common Fermi level (chemical potential  $\mu$ ), whereas all the antibonding  $sp^3$  states (of the  $B_0$  atoms) are above the VB separated by an energy gap. The considerable fraction of antibonding p states below  $\mu^{60}$  supports the assumption of a considerable electron transfer from the A phase to the B phase and corresponds to the conclusion (iii) (Sec. I).

In  $S_{1-x}M_x$  alloys the boundary faces between phase grains of the *different* phases are characterized by the transition from the tetrahedrally coordinated SRO with  $sp^3$  hybrid orbitals [phase B=M(S)] to the close-packed structure typical for metallic phases with  $s^2p$  orbitals<sup>57</sup> [phase A=S(M)]. For those fractions of *S* atoms which are solved in the *M* matrix, the orbital configuration is assumed to be the  $sp^3$  one; the hole density in the VB without considering electron transfer,  $p_0^*$ , is increased with the fraction of *S* atoms solved in the *B* phase, but decreases with increasing A/B phase boundary faces.

In the known metal-metalloid-alloys the M-I transition occurs apparently in the *two-phase* range, i.e., the M-I transition is suggested to occur by percolation of a metallic component. However, there are two essential differences to *classical* percolation theory:<sup>94,104,105</sup> (1) the "metallic" conductivity can be composed of two different conductivity contributions (arising from the two phases A and B), which additionally depend on concentration x. (2) The arrangement of the phase grains is not completely accidental as assumed by percolation theory. Therefore, for the phase separated ranges, the EMT is prefered for a quantitative description of the electronic conductivity  $\sigma$ , where to each of the two phases own transport coefficients are asigned,  $\sigma_i$ ,  $\alpha_i$ ,  $\kappa_{e,i}$ , and  $R_{H,i}$ , for the phase i (i=A, B).

In *disordered*<sup>106</sup>  $N_{1-x}M_x$  and  $T_{1-x}M_x$  alloys,  $\sigma$  decreases with increasing x, as the carrier densities in both the CB and the VB, n and p, respectively, decrease as  $\zeta$  increases.

In  $N_{1-x}M_x$  alloys and in many  $T_{1-x}M_x$  alloys the M-I transition is determined by the VB (phase *B*); however it takes place simultaneously (at the same concentration) in the *A* phase, if  $v_{A,c} < 1/3$ , since in this case electronic transport in the phase *A* takes place by tunneling.

In  $S_{1-x}M_x$  alloys, the M-I transition is determined by the CB (phase A), since the states available in the VB are generally not sufficient for acceptance of all the electrons (enclosed the electrons transferred to the *B* phase) leading to charged phase boundaries. This fact is reason for (1) the granular structure, (2) the rapid decrease of the average phase grain size with increasing x, and (3) the relatively small  $x_c$  (or  $v_{B,c}$ ) as well as for the *fractal* structure in

*r*-Al-Ge developing by annealing of *g*-Al-Ge.

From a critical discussion of the consequences of phase separation regarding the Ioffe-Regel criterion an *alternative* interpretation is proposed: the mean free path, L, cannot be smaller than the mean atomic distance, d; therefore in disordered electronic systems, d is the lower limit for L, and k can be considered as a good quantum number for describing the eigenstates, as long as the Ioffe-Regel criterion  $kL > c^*$  is not violated.  $c^*$  is determined to be 1/4. This alternative inter*pretation* provides the conditions for applicability of both the BTE and NFE approximation for disordered alloys with phase separation. The existence of a minimum metallic conductivity for a homogeneous electronic system or a metallic phase,  $\sigma_{\min} \simeq (c^*/6)(e^2/h)(1/d) \simeq 20 \Omega^{-1} \text{ cm}^{-1}$ , is concluded for the case, that the scattering is strong characterized by L $\simeq d$ , i.e., the M-I transition is concluded to be *discontinuous*. The seemingly contrary experimental finding of both metallic conductivities essentially smaller than 20  $\Omega^{-1}$  cm<sup>-1</sup> and continuous M-I transition in dependence on concentration can be pretended by local concentration fluctuations (e.g., by co-deposition from separated material sources). Smaller  $\sigma_{\min}$  are also to be expected, if  $L{>}d$  because of  $\sigma_{\min}$  $\simeq (c^*/6)(e^2/h)(1/L)$ . The conclusion of a  $\sigma_{\min}$  in the sense as described, involves also the existence of mobility edges which, as consequence of the alternative interpretation of the Ioffe-Regel criterion, can be described for a parabolic band in NFE approximation by Eqs. (50)–(53). For a nonparabolic band the mobility edges can be defined by the density of states, Eqs. (50) and (52), provided effective masses can be defined for  $kL > c^*$ .

Summarizing, Mott's original idea of a minimum metallic conductivity  $\sigma_{\min}$  is supported by the alternative concept described.

The presented calculations are to be considered as example calculations and guide for new experiments which can improve the precision of the results, where experimental data as  $x_A$ ,  $x_B$ ,  $\mathcal{N}_A$ ,  $\mathcal{N}_B$ ,  $D_A$ ,  $D_B$ ,  $\sigma$ ,  $\alpha$ , and  $R_H$  versus x are useful. The necessary transport equations for  $\alpha$  and  $R_H$  combining the EMT with the BTE, analogous to Eqs. (8)–(12) as well as tunneling of electrons for  $v_A < 1/3$  and  $v_B < 1/3$  will be subject of separated papers.

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## **APPENDIX: IOFFE-REGEL CRITERION**

Let us consider the propagation of an electron with the energy  $E_F$  in a disordered homogeneous system characterized by a spherical Fermi surface and a single parabolic band with

$$E_F = \frac{\hbar^2 k_F^2}{2\mathrm{m}}.$$
 (A1)

Under influence of an electric field a single electron at  $E_F$  is accelerated between two successive scattering events covering the path *L*. The amount of its momentum before and after an elastic scattering event is given by  $|p| = (2mE_F)^{1/2}$  and it follows that the amount of the momentum change during scattering,  $|\delta p|$ , cannot be larger than  $2(2mE_F)^{1/2}$ . In accordance with Heisenberg's uncertainty principle the uncertainties of locality,  $\langle \Delta x \rangle$ , and momentum,  $\langle \Delta p \rangle$ , of the electron are determined by<sup>107</sup>

$$\langle \Delta x \rangle \langle \Delta p \rangle \ge \frac{\hbar}{2}.$$
 (A2)

The momentum uncertainty cannot be larger than  $|\delta p|$ , otherwise the momentum change by scattering would not be defined, i.e.:

$$\langle \Delta p \rangle \le |\delta p| \le 2(2mE_F)^{1/2}$$
 (A3)

must be fulfilled. The locality uncertainty,  $\langle \Delta x \rangle$ , cannot be larger than *L*, otherwise *L* would not have a physical sense and with Eqs. (A2) and (A3) it follows  $2L(2mE_F)^{1/2} > \hbar/2$  and with Eq. (A1):

$$k_F L \ge 1/4, \tag{A4}$$

i.e.,  $c^* = 1/4$  (Secs. IV B, IV C, and IV D).

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